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Substitute for	form 1449A/F	PTO		Complete if Known		
<i>*</i> .				Application Number	Net Known 10/705,298	
INFORI	MATION	DISCLO	DSURE	Filing Date	11/10/2003	
STATE	MENT E	SY APPL	ICANT	First Named Inventor	Silver et al.	
				Group Art Unit	2821 2625	
(use	as many she	ets as necess	ary)	Examiner Name	D. Mariam	
Sheet .	1	of	3	Attorney Docket Number	C97-050 CON11	

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Initials*	No.1	Office ³	Number ⁴	Kind Code ^s (<i>if known</i>)	Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear	
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Complete if Known Substitute for form 1449B/PTO Application Number Net-Known 10/705,298 INFORMATION DISCLOSURE Filing Date 11/10/2003 STATEMENT BY APPLICANT First Named Inventor Silver, et al. Group Art Unit 2827 2625 (use as many sheets as necessary) **Examiner Name** D. Mariam Sheet of **Attorney Docket Number** C97-050 CON11

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				Application Number	NetKnown 10/705, 298		
INF	ORMATI	ON DIS	CLOSURE	Filing Date	11/10/2003		
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				Group Art Unit	282 2625		
	(use as man	y sheets as	necessary)	Examiner Name	D. Mariam		
Sheet	3	of	3	Attorney Docket Number	C97-050_CON11		

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